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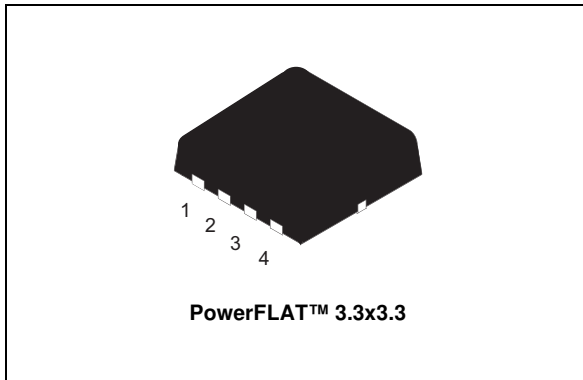
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## N-channel 100 V, 0.062 $\Omega$ typ., 4.5 A STripFET™ VII DeepGATE™ Power MOSFET in a PowerFLAT™ 3.3x3.3 package

Datasheet - production data



### Features

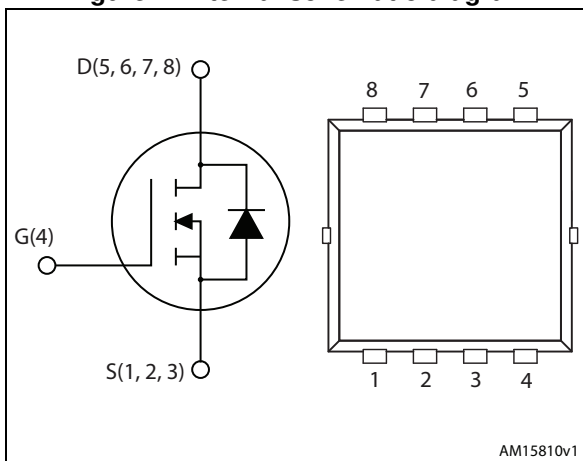
Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STL4N10F7	100 V	0.07 $\Omega$	4.5 A

- N-channel enhancement mode
- Lower R<sub>DS(on)</sub> x area vs previous generation
- 100% avalanche rated

### Applications

- Switching applications

Figure 1. Internal schematic diagram



### Description

This device utilizes the 7<sup>th</sup> generation of design rules of ST's proprietary STripFET™ technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest R<sub>DS(on)</sub> in all packages.

Table 1. Device summary

Order code	Marking	Package	Packaging
STL4N10F7	4N1F7	PowerFLAT™ 3.3x3.3	Tape and reel

# Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-source voltage ( $V_{GS} = 0$ )	100	V
$V_{GS}$	Gate-source voltage	$\pm 20$	V
$I_D^{(1)}$	Drain current (continuous) at $T_{amb} = 25\text{ }^\circ\text{C}$	4.5	A
$I_D^{(1)}$	Drain current (continuous) at $T_{amb}=100\text{ }^\circ\text{C}$	3.2	A
$I_{DM}^{(1)(2)}$	Drain current (pulsed)	18	A
$I_D^{(3)}$	Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$	18	A
$I_D^{(3)}$	Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$	11.25	A
$I_{DM}^{(2)(3)}$	Drain current (pulsed)	72	A
$P_{TOT}^{(3)}$	Total dissipation at $T_C = 25\text{ }^\circ\text{C}$	50	W
$P_{TOT}^{(1)}$	Total dissipation at $T_{amb} = 25\text{ }^\circ\text{C}$	2.9	W
$T_J$	Operating junction temperature	-55 to 150	$^\circ\text{C}$
$T_{stg}$	Storage temperature		$^\circ\text{C}$

1. The value is rated according to  $R_{thj-amb}$
2. Pulse width limited by safe operating area.
3. This value is rated according to  $R_{thj-case}$

**Table 3. Thermal resistance**

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case	2.50	$^\circ\text{C}/\text{W}$
$R_{thj-amb}^{(1)}$	Thermal resistance junction-amb	42.8	$^\circ\text{C}/\text{W}$
$R_{thj-amb}^{(2)}$	Thermal resistance junction-amb	63.5	$^\circ\text{C}/\text{W}$

1. When mounted on FR-4 board of 1inch<sup>2</sup>, 2oz Cu,  $t < 10\text{sec}$
2. When mounted on FR-4 board of 1inch<sup>2</sup>, 2oz Cu, steady state

## 2 Electrical characteristics

( $T_{CASE}=25\text{ °C}$  unless otherwise specified)

**Table 4. On/off states**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$I_D = 250\ \mu A, V_{GS} = 0$	100			V
$I_{DSS}$	Zero gate voltage drain current ( $V_{GS} = 0$ )	$V_{DS} = 100\text{ V}$			1	$\mu A$
		$V_{DS} = 100\text{ V}, T_C = 125\text{ °C}$			100	$\mu A$
$I_{GSS}$	Gate body leakage current ( $V_{DS} = 0$ )	$V_{GS} = +20\text{ V}$			100	nA
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250\ \mu A$	2.5		4.5	V
$R_{DS(on)}$	Static drain-source on-resistance	$V_{GS} = 10\text{ V}, I_D = 2.25\text{ A}$		0.062	0.07	$\Omega$

**Table 5. Dynamic**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$C_{iss}$	Input capacitance	$V_{DS} = 50\text{ V}, f = 1\text{ MHz}, V_{GS} = 0$	-	408	-	pF
$C_{oss}$	Output capacitance		-	112	-	pF
$C_{rss}$	Reverse transfer capacitance		-	10	-	pF
$Q_g$	Total gate charge	$V_{DD} = 50\text{ V}, I_D = 4.5\text{ A}$ $V_{GS} = 10\text{ V}$ <i>(see Figure 14)</i>	-	7.8	-	nC
$Q_{gs}$	Gate-source charge		-	3	-	nC
$Q_{gd}$	Gate-drain charge		-	1.7	-	nC

**Table 6. Switching times**

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 50\text{ V}, I_D = 2.25\text{ A}, R_G = 4.7\ \Omega, V_{GS} = 10\text{ V}$ <i>(see Figure 13)</i>	-	6.3	-	ns
$t_r$	Rise time		-	3	-	ns
$t_{d(off)}$	Turn-off delay time		-	11	-	ns
$t_f$	Fall time		-	4	-	ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$I_{SD}$	Source-drain current		-		4.5	A
$I_{SDM}^{(1)}$	Source-drain current (pulsed)		-		18	A
$V_{SD}^{(2)}$	Forward on voltage	$I_{SD}= 2.25\text{ A}$ , $V_{GS}=0$	-		1.1	V
$t_{rr}$	Reverse recovery time	$I_{SD}= 2.25\text{ A}$ , $di/dt = 100\text{ A}/\mu\text{s}$ , $V_{DD}= 80\text{ V}$ , $T_J=150\text{ }^\circ\text{C}$ <i>(see Figure 18)</i>	-	30		ns
$Q_{rr}$	Reverse recovery charge		-	24		nC
$I_{RRM}$	Reverse recovery current		-	1.6		A

1. Pulse width limited by safe operating area.
2. Pulsed: pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5 %

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

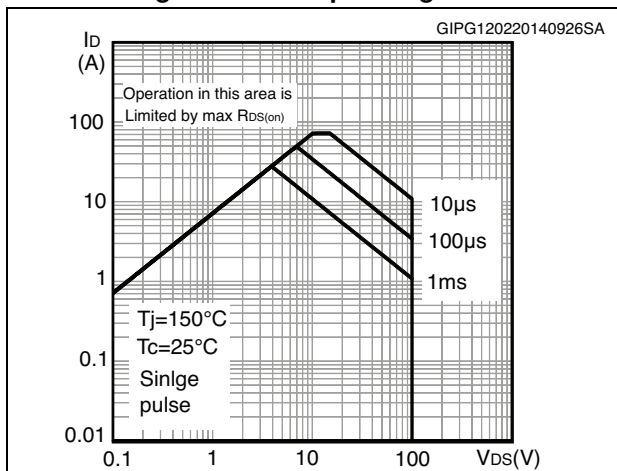


Figure 3. Thermal impedance

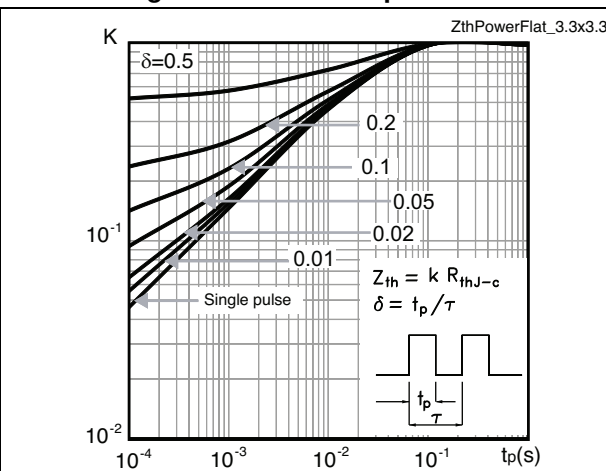


Figure 4. Output characteristics

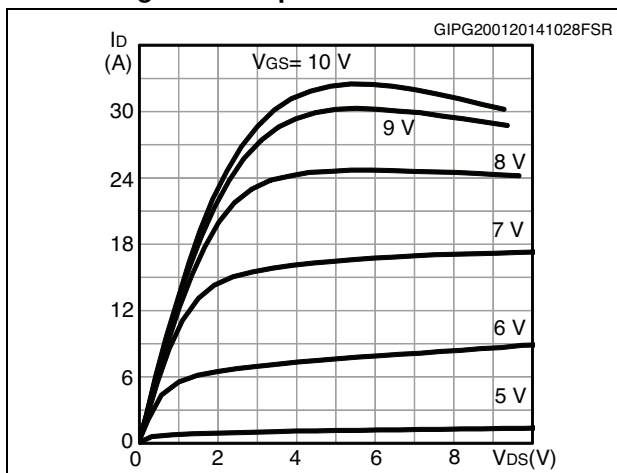


Figure 5. Transfer characteristics

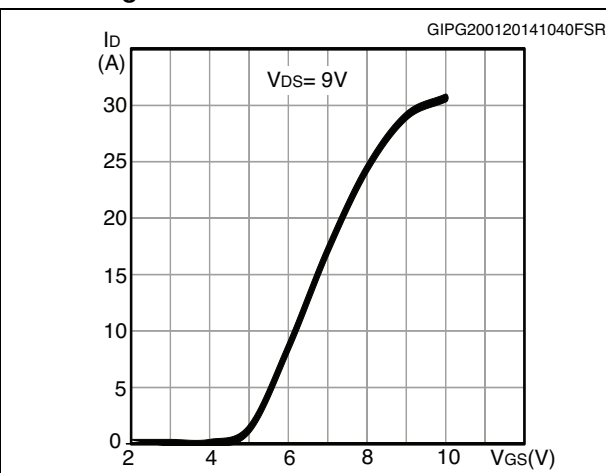


Figure 6. Gate charge vs gate-source voltage

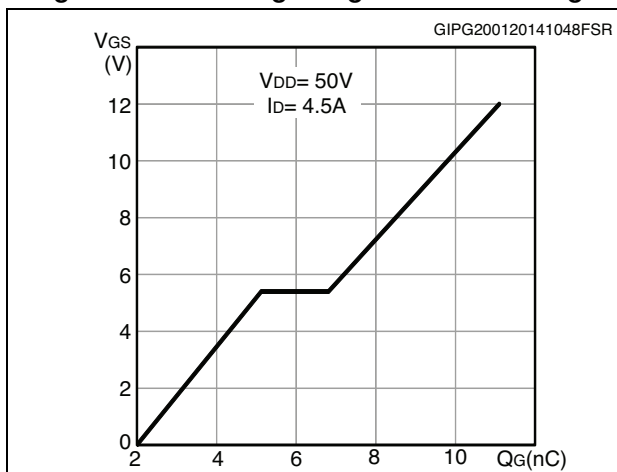


Figure 7. Static drain-source on-resistance

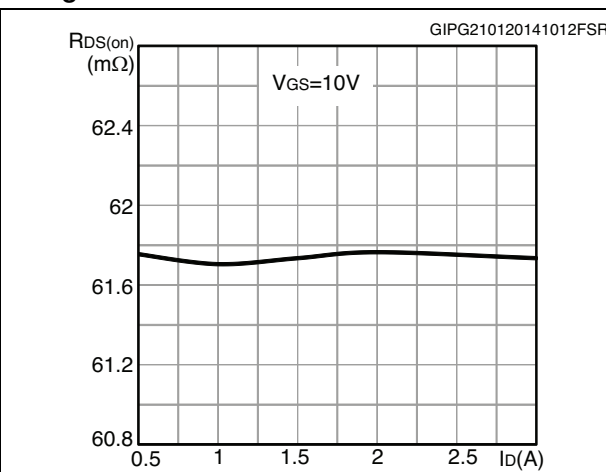


Figure 8. Capacitance variations

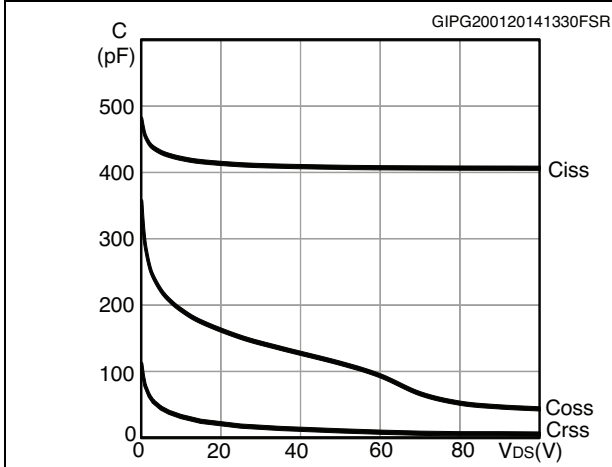


Figure 9. Normalized  $V_{(BR)DSS}$  vs temperature

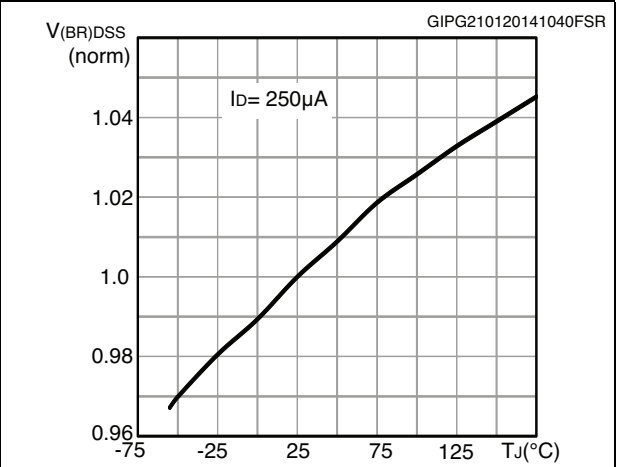


Figure 10. Normalized gate threshold voltage vs temperature

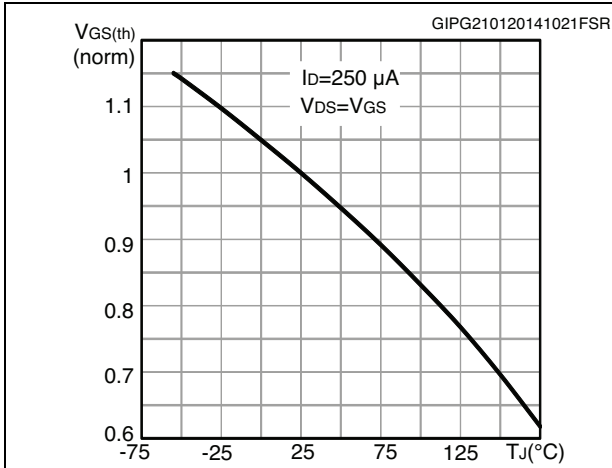


Figure 11. Normalized on-resistance vs temperature

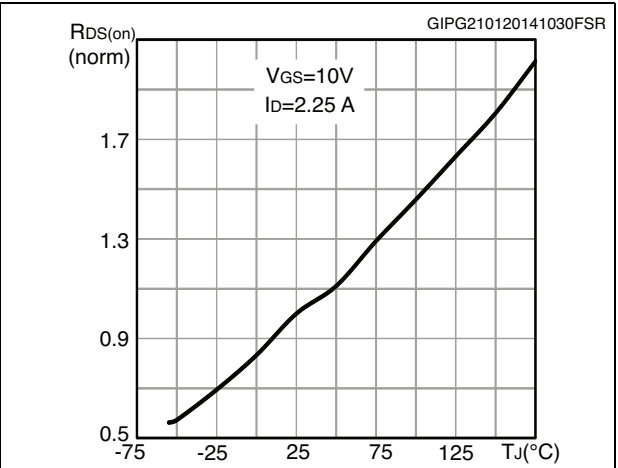
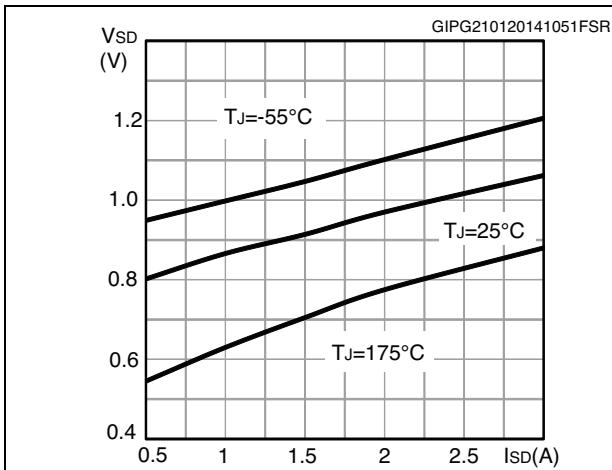


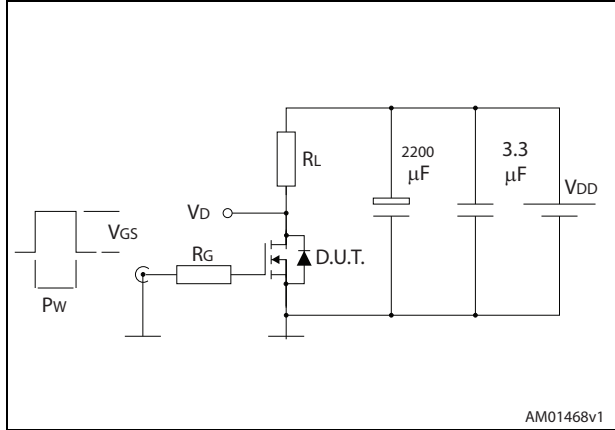
Figure 12. Source-drain diode forward characteristics





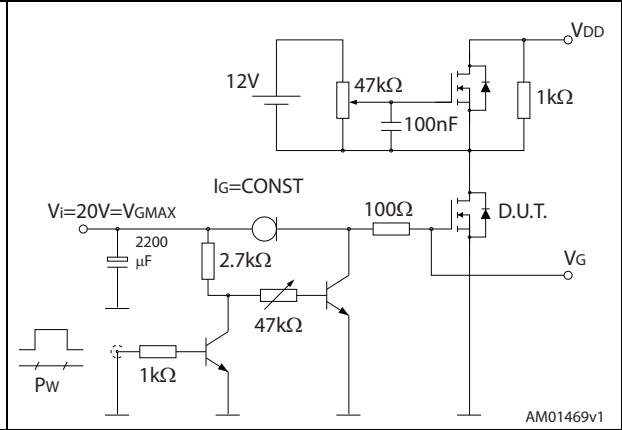
### 3 Test circuits

**Figure 13. Switching times test circuit for resistive load**



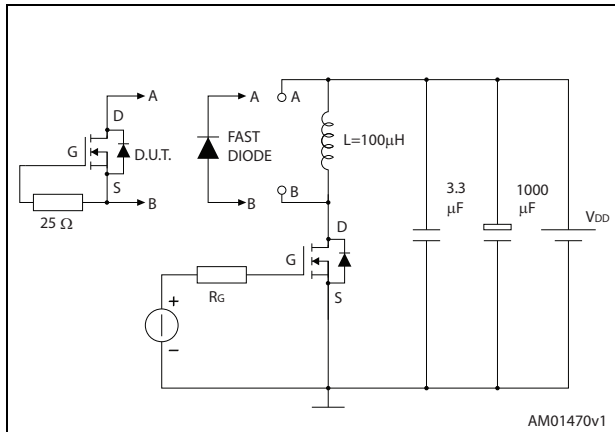
AM01468v1

**Figure 14. Gate charge test circuit**



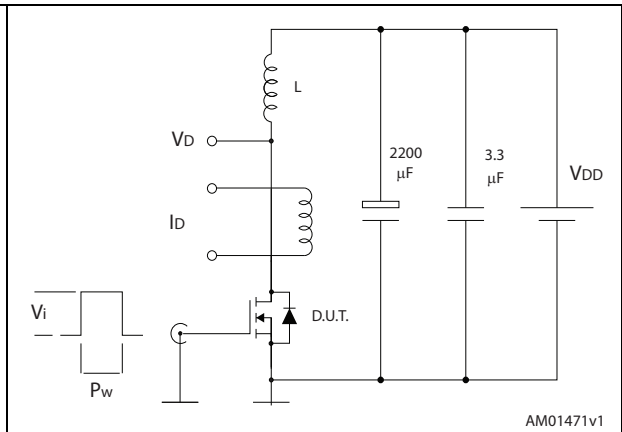
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**Figure 15. Test circuit for inductive load switching and diode recovery times**



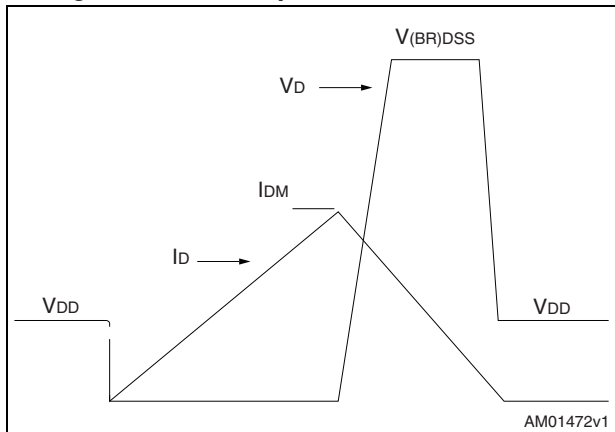
AM01470v1

**Figure 16. Unclamped inductive load test circuit**



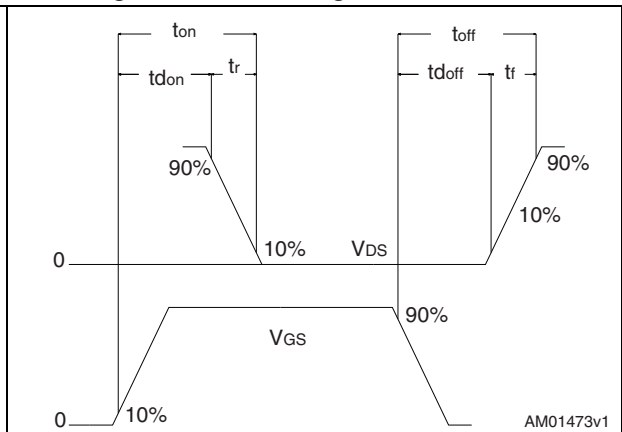
AM01471v1

**Figure 17. Unclamped inductive waveform**



AM01472v1

**Figure 18. Switching time waveform**



AM01473v1

## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK<sup>®</sup> is an ST trademark.

Figure 19. PowerFLAT™ 3.3 x 3.3 drawing

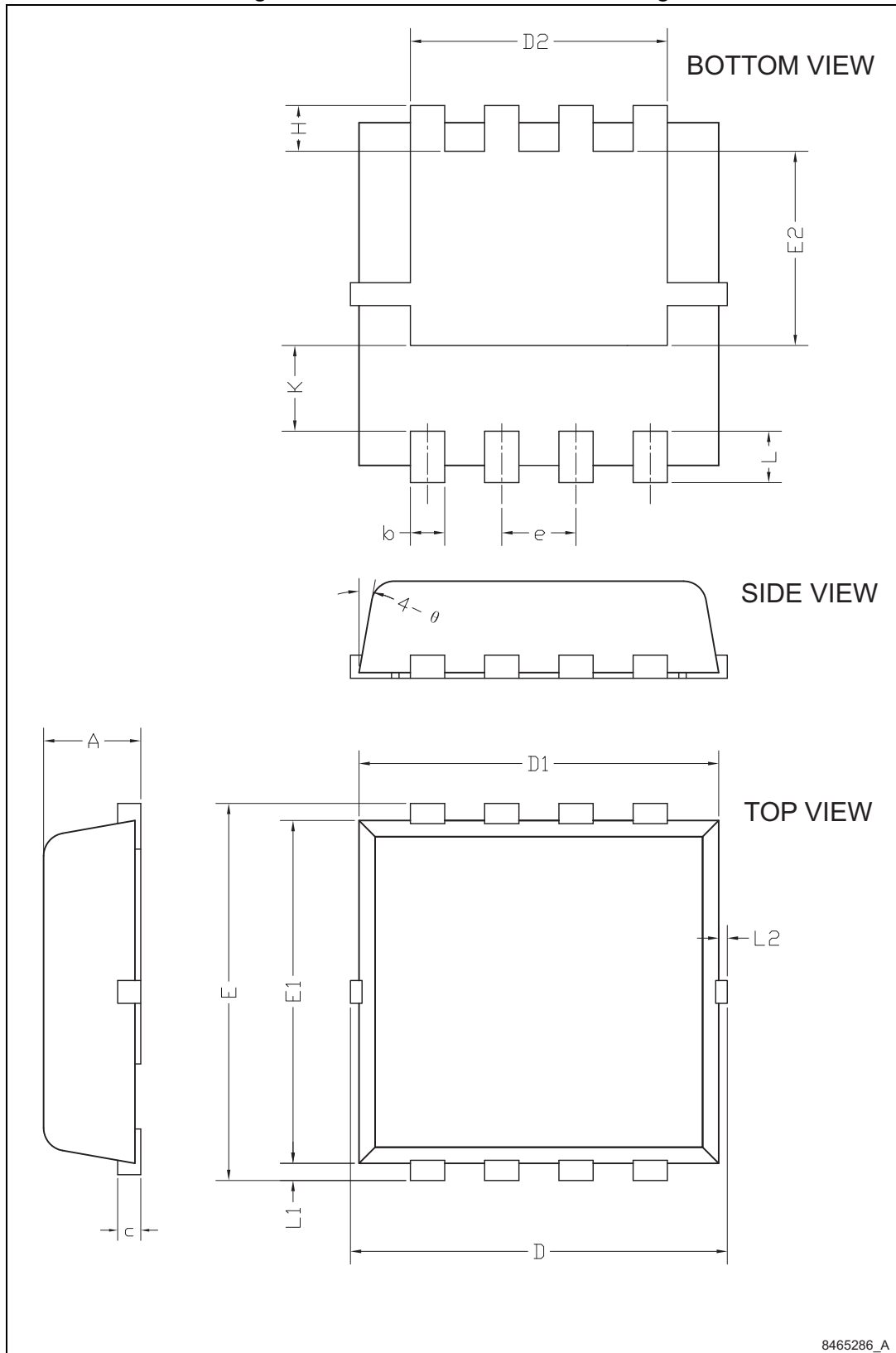
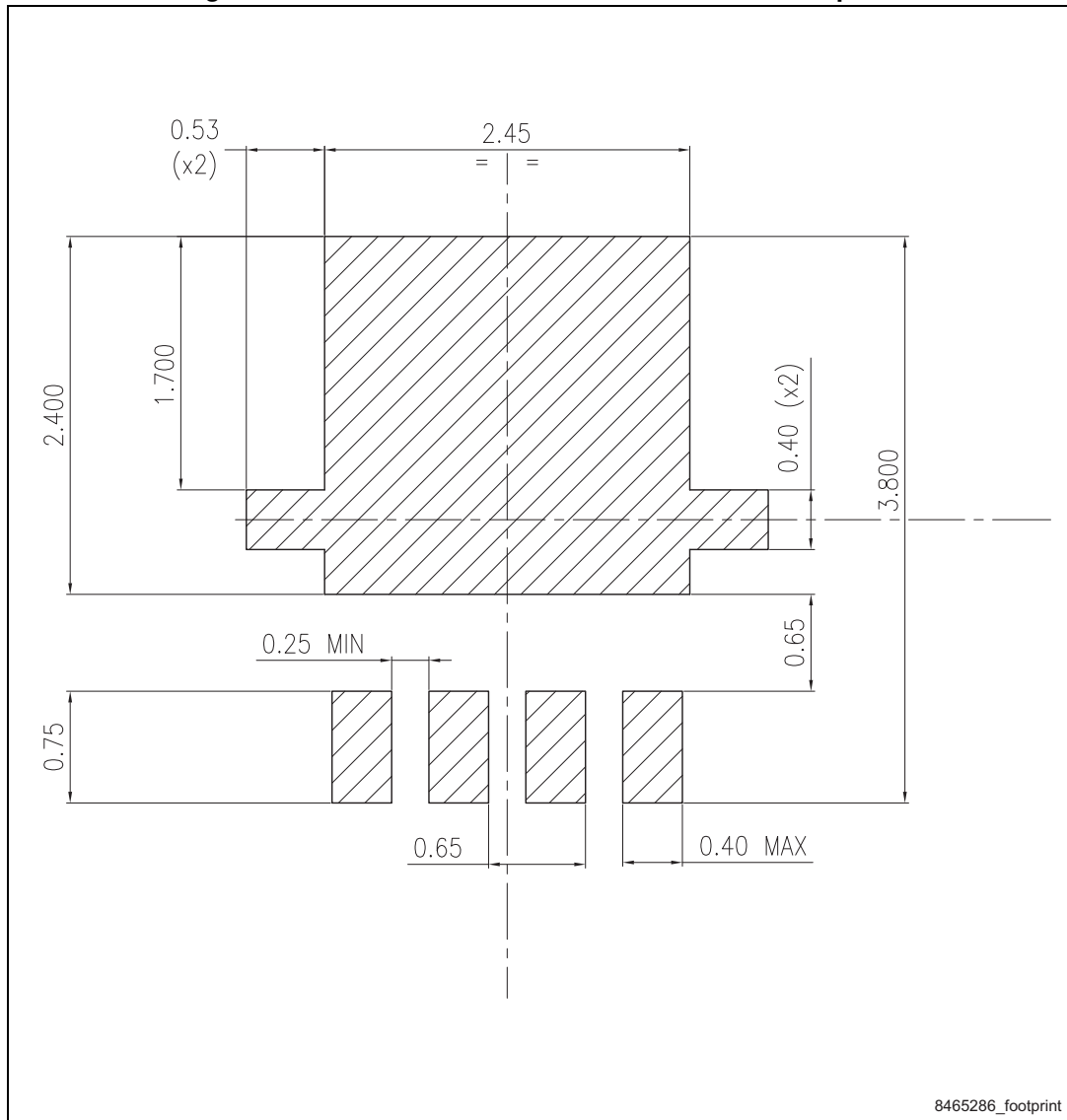


Table 8. PowerFLAT™ 3.3 x 3.3 mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	0.70	0.80	0.90
b	0.25	0.30	0.39
c	0.14	0.15	0.20
D	3.10	3.30	3.50
D1	3.05	3.15	3.25
D2	2.15	2.25	2.35
e	0.55	0.65	0.75
E	3.10	3.30	3.50
E1	2.90	3.00	3.10
E2	1.60	1.70	1.80
H	0.25	0.40	0.55
K	0.65	0.75	0.85
L	0.30	0.45	0.60
L1	0.05	0.15	0.25
L2			0.15
∠	8°	10°	12°

Figure 20. PowerFLAT™ 3.3 x 3.3 recommended footprint



8465286\_footprint

## 5 Revision history

**Table 9. Document revision history**

Date	Revision	Changes
10-Jul-2013	1	First release.
21-Jan-2014	2	– Inserted <a href="#">Section 2.1: Electrical characteristics (curves)</a> . – Document status promoted from preliminary to production data.
19-Feb-2014	3	– Added: $I_D$ (at $T_C=25\text{ °C}$ and $125\text{ °C}$ ), $I_{DM}$ and $P_{TOT}$ in <a href="#">Table 2</a> – Modified: <a href="#">Figure 2</a> and <a href="#">3</a> – Minor text changes
10-Mar-2014	4	– Modified: marking in <a href="#">Table 1</a> – Minor text changes

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